

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the application of:	)
,	) Group Art Unit: 1765
GOTKIS	)
A 11 11 NY 10/010 000	) Examiner: Anita Karen Alanko
Application No: 10/810,209	) Atty. Dooleat No. 1 AM2D466
Filed: March 26, 2004	) Atty. Docket No: LAM2P466
	) Date: July 5, 2006
For: METHOD AND APPARATUS FOR	)
MEASUREMENT OF THIN FILMS AND	)
RESIDUES ON SEMICONDUCTOR	)
SUBSTRATES	)

## **CERTIFICATE OF MAILING**

I hereby certify that this correspondence is being deposited with the United States Postal Service as First Class Mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on July 5, 2006.

Signed:

Kay Harky

Mail Stop: **AF**Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

## **AMENDMENT**

Dear Sir:

This Amendment is submitted in response to the Office Action dated April 5, 2006, a response is due by July 5, 2006. An RCE is being submitted with this paper. Please enter the following amendments and remarks.

Amendments to the Claims are reflected in the listing of claims, which begins on page 2 of this Amendment.

Remarks/Arguments begin on page 6 of this Amendment.